## Notice of References Cited Application/Control No. 10/599,862 Examiner NICHOLAS LEE Applicant(s)/Patent Under Reexamination LEE ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0145995 a1	07-2004	Saito et al.	369/110.02
*	В	US-5,620,068	04-1997	Garnjost et al.	188/378
*	С	US-5,760,992	06-1998	Phan et al.	360/78.07
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-			
	-	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
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	х						

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